Notice of References Cited Application/Control No. 10/574,587 Applicant(s)/Patent Under Reexamination KIKUCHI ET AL. Examiner Jonathan Sample Application/Control No. 10/574,587 Applicant(s)/Patent Under Reexamination KIKUCHI ET AL. Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,543,572 A	09-1985	Tanaka et al.	701/201
*	В	US-5,291,413 A	03-1994	Tamai et al.	701/210
*	C	US-5,712,632 A	01-1998	Nishimura et al.	340/995.19
*	D	US-5,926,118 A	07-1999	Hayashida et al.	340/995.21
*	Е	US-5,944,768 A	08-1999	Ito et al.	701/200
*	F	US-6,014,607 A	01-2000	Yagyu et al.	701/202
*	G	US-6,034,626 A	03-2000	Maekawa et al.	340/995.21
*	Ι	US-6,212,473 B1	04-2001	Stefan et al.	701/210
*	I	US-6,466,869 B2	10-2002	Yamashita et al.	701/211
*	J	US-2002/0165668 A1	11-2002	Yamashita et al.	701/211
*	K	US-6,574,552 B2	06-2003	Yano et al.	701/209
*	L	US-6,591,189 B2	07-2003	Shimada, Yasuyuki	701/209
*	М	US-2003/0182052 A1	09-2003	DeLorme et al.	701/201

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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Notice of References Cited Application/Control No. 10/574,587 Examiner Jonathan Sample Applicant(s)/Patent Under Reexamination KIKUCHI ET AL. Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0066330 A1	04-2004	Knockeart et al.	342/357.07
*	В	US-6,784,832 B2	08-2004	Knockeart et al.	342/357.13
*	O	US-2005/0027447 A1	02-2005	Hirose et al.	701/210
*	D	US-2005/0192742 A1	09-2005	Okochi, Masaru	701/209
*	Е	US-2006/0064243 A1	03-2006	Hirose, Koji	701/211
*	F	US-2006/0064239 A1	03-2006	Ishii, Naoki	701/200
*	O	US-7,184,886 B1	02-2007	Krull et al.	701/209
*	Η	US-2007/0156334 A1	07-2007	Vu, Tien	701/209
*	Ι	US-7,409,288 B1	08-2008	Krull et al.	701/209
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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